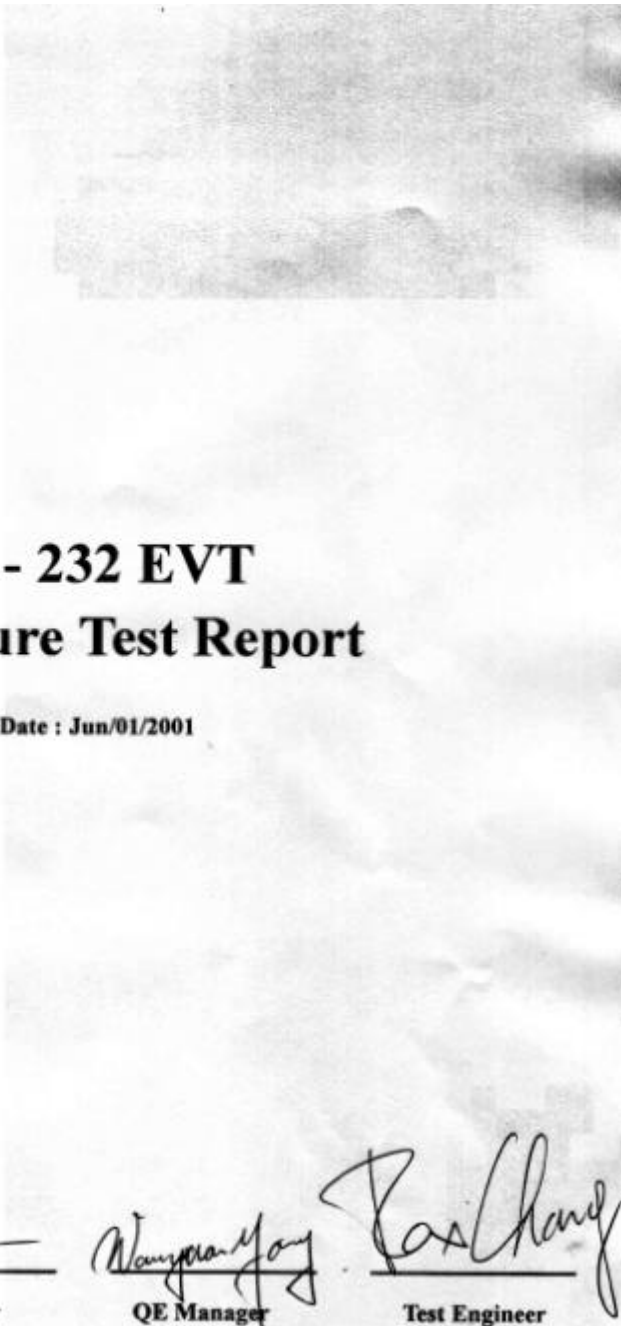


# **AAEON**

AAEON Technology INC.  
ISO-9001/ISO-14001 Certified  
Industrial Automation PCs



## **AMB - 232 EVT Temperature Test Report**

Release Date : Jun/01/2001

\_\_\_\_\_  
Issue Stamp

*Jason*  
\_\_\_\_\_  
QA Manager

*Wangyan Yang*  
\_\_\_\_\_  
QE Manager

*Pas Chang*  
\_\_\_\_\_  
Test Engineer

# Environment

**Model Name :** AMB-232 EVT

**Test Date :** 01-06-01

**Test Site :** AAEON QE Dept.

**Performed by :** Rex Chang

**Test Standard :**

Select	NO.	Description
√	IEC 68-2-61	Test Z/ABD : Climatic Sequence Test

**Testing Item :**

Temperature & Humidity Cycle

**Additional Test Peripheral :**

Configuration	Model
Test Software	Run QAPlus 5.5

**Testing Equipment :**

- Programmable Temperature & Humidity Chamber  
Model : Ths-D4L+-100
- S/N : 1241  
Date of Calibration : 07-10-1998

**Sample Configuration & Quantity Under Test :**

**System Information :**

**Display :** AMB-232 10.4"(800X600) TFT color LCD

**System :**

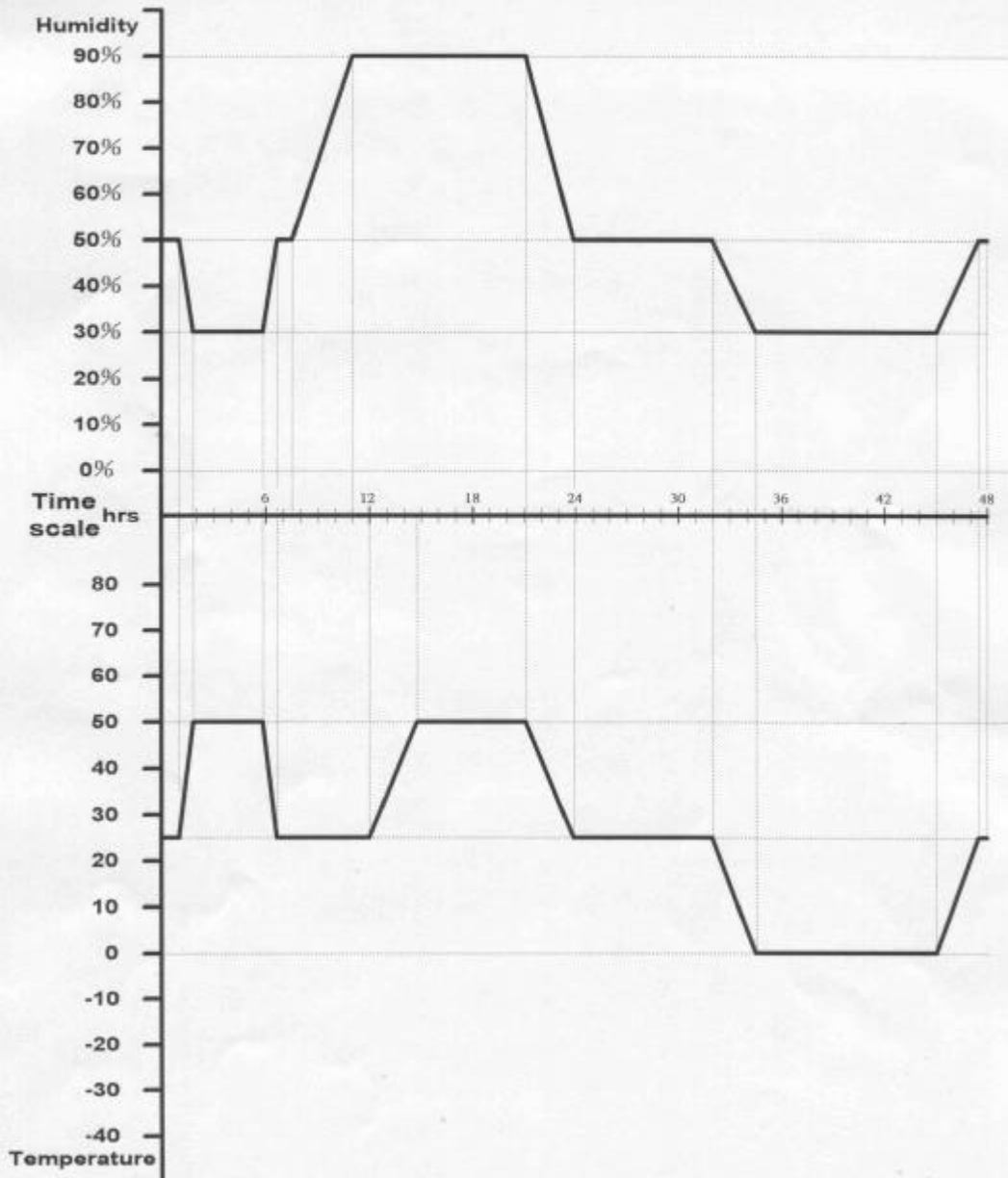
1. Chipset: Intel 430TX
2. CPU: Cyrix PR200 MHz
3. Memory: 64M SDRAM
4. VGA: ATI 3D RAGE2+DVD (215GT2UB23)

**Test Result :**

Standard	Description	Result
IEC 68-2-61	Temperature & Humidity Cycle Test (Run QAPlusfe 5.5)	Pass

# Environment

Temperature & Humidity Cycle Test(Run QAPlusfe 5.5)



# Environment

Temperature & Humidity Cycle Test(Run QAPlusfe 5.5)

